

# SN74LV1T125 Single Power Supply Single Buffer Gate with 3-State Output CMOS Logic Level Shifter

## 1 Features

- Single-supply voltage translator at 5V, 3.3V, 2.5V, and 1.8V  $V_{CC}$
- Operating range of 1.8V to 5.5V
- Up translation:
  - 1.2V<sup>(1)</sup> to 1.8V at 1.8V  $V_{CC}$
  - 1.5V<sup>(1)</sup> to 2.5V at 2.5V  $V_{CC}$
  - 1.8V<sup>(1)</sup> to 3.3V at 3.3V  $V_{CC}$
  - 3.3V to 5.0V at 5.0V  $V_{CC}$
- Down translation:
  - 3.3V to 1.8V at 1.8V  $V_{CC}$
  - 3.3V to 2.5V at 2.5V  $V_{CC}$
  - 5.0V to 3.3V at 3.3V  $V_{CC}$
- Logic output is referenced to  $V_{CC}$
- Output drive:
  - 8.0mA output drive at 5V
  - 7.0mA output drive at 3.3V
  - 3.0mA output drive at 1.8V
- Characterized up to 50MHz at 3.3V  $V_{CC}$
- 5.0V tolerance on input pins
- –40°C to 125°C operating temperature range
- Latch-up performance exceeds 250mA per JESD 17

- Supports standard logic pinouts
- CMOS output B compatible with AUP1G and LVC1G families <sup>1</sup>

## 2 Applications

- [Telecom](#)
- [Portable applications](#)
- [Servers](#)
- [PC and notebooks](#)

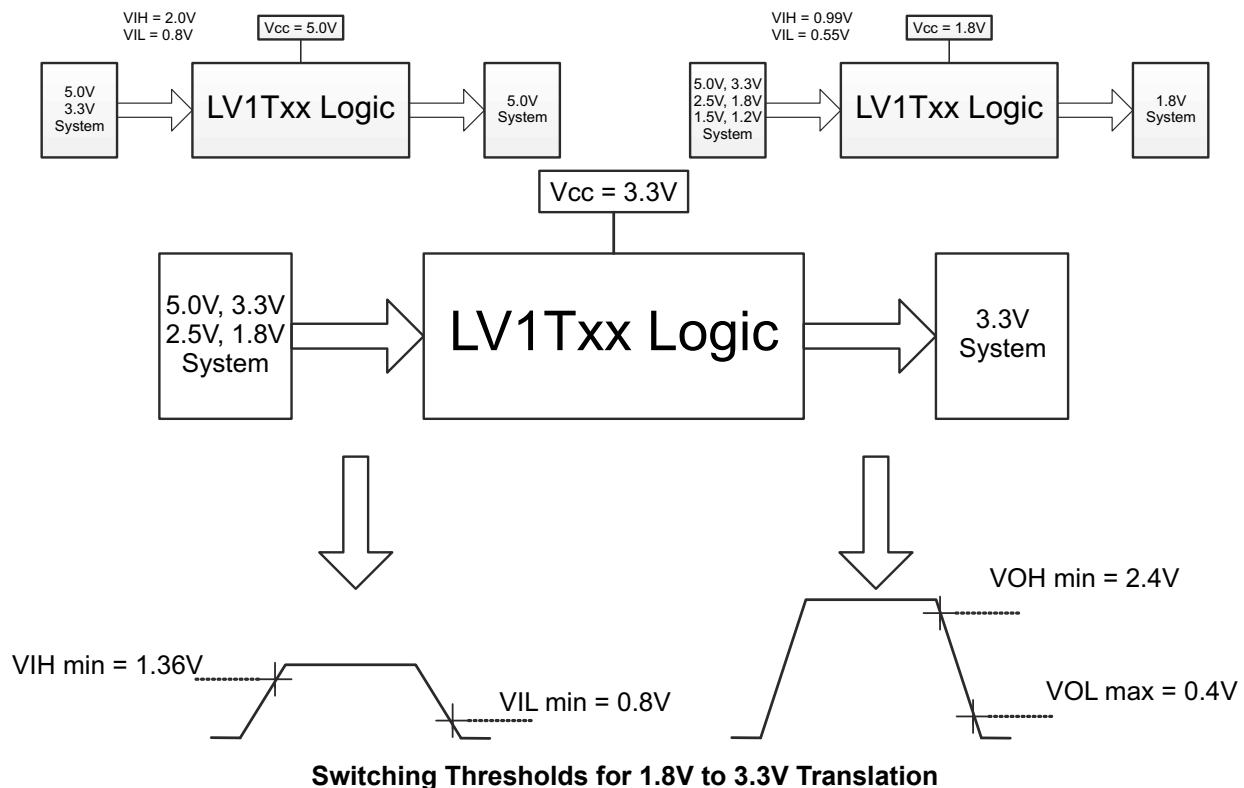
## 3 Description

The SN74LV1T125 is a single buffer gate with reduced input thresholds to support voltage translation applications.

### Package Information

PART NUMBER	PACKAGE <sup>(1)</sup>	PACKAGE SIZE <sup>(2)</sup>	BODY SIZE <sup>(3)</sup>
SN74LV1T125	DBV (SOT-23, 5)	2.90mm × 2.8mm	2.9mm × 1.6mm
	DCK (SC70, 5)	2.00mm × 2.1mm	2mm × 1.25mm

- (1) For more information, see [Section 12](#).
- (2) The package size (length × width) is a nominal value and includes pins, where applicable.
- (3) The body size (length × width) is a nominal value and does not include pins.



<sup>1</sup> Refer to the  $V_{IH}/V_{IL}$  and output drive for lower  $V_{CC}$  condition.



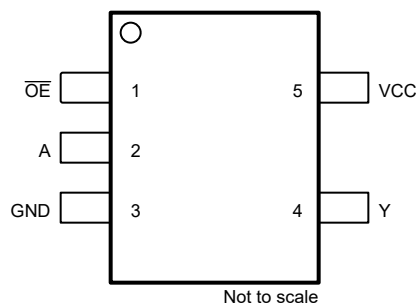
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## 4 Related Products

DEVICE	PACKAGE	DESCRIPTION
SN74LV1T00	DCK, DBV	2-Input Positive-NAND Gate
SN74LV1T02	DCK, DBV	2-Input Positive-NOR Gate
SN74LV1T04	DCK, DBV	Inverter Gate
SN74LV1T08	DCK, DBV	2-Input Positive-AND Gate
SN74LV1T17	DCK, DBV	Single Schmitt-Trigger Buffer Gate
SN74LV1T14	DCK, DBV	Single Schmitt-Trigger Inverter Gate
SN74LV1T32	DCK, DBV	2-Input Positive-OR Gate
SN74LV1T34	DCK, DBV	Single Buffer Gate
SN74LV1T86	DCK, DBV	Single 2-Input Exclusive-Or Gate
SN74LV1T125	DCK, DBV	Single Buffer Gate with 3-state Output
SN74LV1T126	DCK, DBV	Single Buffer Gate with 3-state Output
SN74LV4T125	RGY, PW	Quadruple Bus Buffer Gate With 3-State Outputs

## 5 Pin Configuration and Functions



**Figure 5-1. DCK or DBV Package, 5-Pin SC70 or SOT-23 (Top View)**

**Table 5-1. Pin Functions**

PIN		TYPE <sup>(1)</sup>	DESCRIPTION
NAME	NO.		
$\overline{OE}$	1	I	Output enable, active low
A	2	I	Input A
GND	3	G	Ground
Y	4	O	Output Y
V <sub>CC</sub>	5	P	Positive supply

(1) I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range	−0.5	7.0	V
V <sub>I</sub>	Input voltage range <sup>(2)</sup>	−0.5	7.0	V
V <sub>O</sub>	Voltage range applied to any output in the high or low state <sup>(2)</sup>	−0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		−20 mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub>		±20 mA
I <sub>O</sub>	Continuous output current			±25 mA
	Continuous current through V <sub>CC</sub> or GND			±50 mA
T <sub>J</sub>	Junction temperature			150 °C
T <sub>stg</sub>	Storage temperature	−65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000
		Machine Model (MM), per JEDEC specification	±200
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002 <sup>(2)</sup>	±1000

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	1.6	5.5	V
V <sub>I</sub>	Input voltage	0	5.5	V
V <sub>O</sub>	Output voltage	0	V <sub>CC</sub>	V
I <sub>OH</sub>	High-level output current	V <sub>CC</sub> = 1.8 V	−3	mA
		V <sub>CC</sub> = 2.5 V	−5	
		V <sub>CC</sub> = 3.3 V	−7	
		V <sub>CC</sub> = 5.0 V	−8	
I <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 1.8 V	3	mA
		V <sub>CC</sub> = 2.5 V	5	
		V <sub>CC</sub> = 3.3 V	7	
		V <sub>CC</sub> = 5.0 V	8	
Δt/Δv	Input transition rise or fall rate	V <sub>CC</sub> = 1.8 V	20	ns/V
		V <sub>CC</sub> = 3.3 V or 2.5 V	20	
		V <sub>CC</sub> = 5.0 V	20	
T <sub>A</sub>	Operating free-air temperature	−40	125	°C

- (1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

## 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		DBV	DCK	UNIT
		5 PINS	5 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	278	289.2	°C/W

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

## 6.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$V_{CC}$	$T_A = 25^\circ\text{C}$			$T_A = -40^\circ\text{C to } +125^\circ\text{C}$			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
$V_{IH}$	High-level input voltage	$V_{CC} = 1.65\text{ V to } 1.8\text{ V}$	0.95			1			V
		$V_{CC} = 2.0\text{ V}$	0.99			1.03			
		$V_{CC} = 2.25\text{ V to } 2.5\text{ V}$	1.145			1.18			
		$V_{CC} = 2.75\text{ V}$	1.22			1.25			
		$V_{CC} = 3\text{ V to } 3.3\text{ V}$	1.37			1.39			
		$V_{CC} = 3.6\text{ V}$	1.47			1.48			
		$V_{CC} = 4.5\text{ V to } 5.0\text{ V}$	2.02			2.03			
		$V_{CC} = 5.5\text{ V}$	2.1			2.11			
$V_{IL}$	Low-level input voltage	$V_{CC} = 1.65\text{ V to } 2.0\text{ V}$			0.57			0.55	V
		$V_{CC} = 2.25\text{ V to } 2.75\text{ V}$			0.75			0.71	
		$V_{CC} = 3\text{ V to } 3.6\text{ V}$			0.8			0.65	
		$V_{CC} = 4.5\text{ V to } 5.5\text{ V}$			0.8			0.8	
$V_{OH}$	High-level output voltage	$I_{OH} = -20\text{ }\mu\text{A}$	1.65 V to 5.5 V	$V_{CC} - 0.1$		$V_{CC} - 0.1$			V
		$I_{OH} = -2.0\text{ mA}$	1.65 V	1.28		1.21			
			1.8 V	1.5		1.45			
		$I_{OH} = -3\text{ mA}$	2.3 V	2		1.93			
		$I_{OH} = -3\text{ mA}$	2.5 V	2.25		2.15			
		$I_{OH} = -3.0\text{ mA}$	3.0 V	2.78		2.7			
		$I_{OH} = -5.5\text{ mA}$		2.6		2.49			
		$I_{OH} = -5.5\text{ mA}$	3.3 V	2.9		2.8			
		$I_{OH} = -4\text{ mA}$	4.5 V	4.2		4.1			
		$I_{OH} = -8\text{ mA}$		4.1		3.95			
		$I_{OH} = -8\text{ mA}$	5.0 V	4.6		4.5			
$V_{OL}$	Low-level output voltage	$I_{OL} = 20\text{ }\mu\text{A}$	1.65 V to 5.5 V		0.1			0.1	V
		$I_{OL} = 2\text{ mA}$	1.65 V		0.2			0.25	
		$I_{OL} = 3\text{ mA}$	2.3 V		0.15			0.2	
		$I_{OL} = 3\text{ mA}$	3.0 V		0.11			0.15	
		$I_{OL} = 5.5\text{ mA}$			0.21			0.252	
		$I_{OL} = 4\text{ mA}$	4.5 V		0.15			0.2	
		$I_{OL} = 8\text{ mA}$			0.3			0.35	
$I_I$	Input leakage current	A input; $V_I = 0\text{ V or } V_{CC}$	0 V, 1.8 V, 2.5 V, 3.3 V, 5.5 V		0.1			$\pm 1$	$\mu\text{A}$
$I_{CC}$	Static supply current	$V_I = 0\text{ V or } V_{CC}$ , $I_O = 0$ ; open on loading	5.0 V		1			10	$\mu\text{A}$
			3.3 V		1			10	
			2.5 V		1			10	
			1.8 V		1			10	

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	T <sub>A</sub> = 25°C			T <sub>A</sub> = –40°C to +125°C			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
$\Delta I_{CC}$ Additional static supply current	One input at 0.3 V or 3.4 V, Other inputs at 0 or V <sub>CC</sub> , I <sub>O</sub> = 0	5.5 V			1.35			1.5	mA
	One input at 0.3 V or 1.1 V, Other inputs at 0 or V <sub>CC</sub> , I <sub>O</sub> = 0	1.8 V			10			10	μA
C <sub>i</sub> Input capacitance	V <sub>I</sub> = V <sub>CC</sub> or GND	3.3 V		2	10		2	10	pF
C <sub>o</sub> Output capacitance	V <sub>O</sub> = V <sub>CC</sub> or GND	3.3 V		2.5			2.5		pF

## 6.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

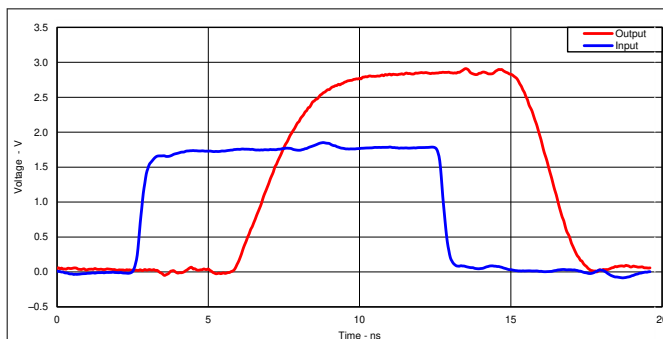
PARAMETER	FROM (INPUT)	TO (OUTPUT)	FREQUENCY (TYP)	V <sub>CC</sub>	C <sub>L</sub>	T <sub>A</sub> = 25°C			T <sub>A</sub> = –65°C to 125°C			UNIT
						MIN	TYP	MAX	MIN	TYP	MAX	
t <sub>pd</sub>	Any In	Y	DC to 50 MHz	5.0 V	15 pF		2.7	5.5		3.4	6.5	ns
					30 pF		3.0	6.5		4.1	7.5	
				3.3 V	15 pF		4.0	7.0		5.0	8.0	ns
					30 pF		4.9	8.0		6.0	9.0	
			DC to 25 MHz	2.5 V	15 pF		5.8	8.5		6.8	9.5	ns
					30 pF		6.5	9.5		7.5	10.5	
t <sub>pZH</sub> , t <sub>pZL</sub>	OE	Y	DC to 50 MHz	5.0 V	15 pF		3.0	5.0		3.5	6.0	ns
					30 pF		4.3	6.5		4.9	7.5	
				3.3 V	15 pF		4.0	6.5		4.5	7.5	ns
					30 pF		5.0	8.0		6.5	9.0	
			DC to 25 MHz	2.5 V	15 pF		5.5	8.0		6.1	9.0	ns
					30 pF		7.0	10.0		8.5	11.0	
t <sub>pHZ</sub> , t <sub>pLZ</sub>	OE	Y	DC to 50 MHz	5.0 V	15 pF		4.2	6.5		4.5	7.0	ns
					30 pF		4.8	8.0		5.0	8.5	
				3.3 V	15 pF		4.5	7.0		5.0	8.0	ns
					30 pF		5.0	8.0		5.5	9.0	
			DC to 25 MHz	2.5 V	15 pF		5.0	11.0		6.0	9.0	ns
					30 pF		6.0	9.0		7.0	10.0	
			DC to 15 MHz	1.8 V	15 pF		8.0	10.0		8.5	11.0	ns
					30 pF		8.5	11.0		9.5	12.0	

## 6.7 Operating Characteristics

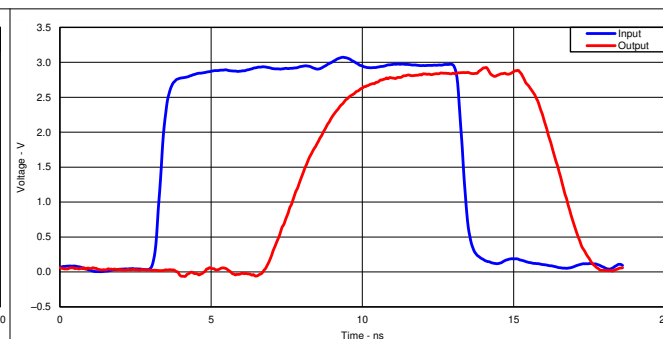
T<sub>A</sub> = 25°C

PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	TYP	UNIT
C <sub>pd</sub> Power dissipation capacitance	f = 1 MHz and 10 MHz	1.8 V ± 0.15 V	14	pF
		2.5 V ± 0.2 V	14	
		3.3 V ± 0.3 V	14	
		5.5 V ± 0.5 V	14	

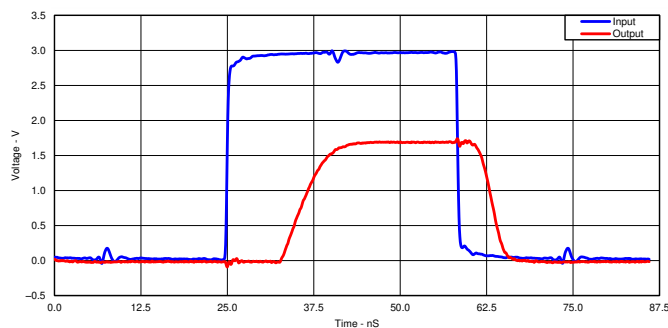
## 6.8 Typical Characteristics



**Figure 6-1. Switching Characteristics at 50 MHz**  
Excellent Signal Integrity  
(1.8 V to 3.3 V at 3.3-V  $V_{CC}$ )



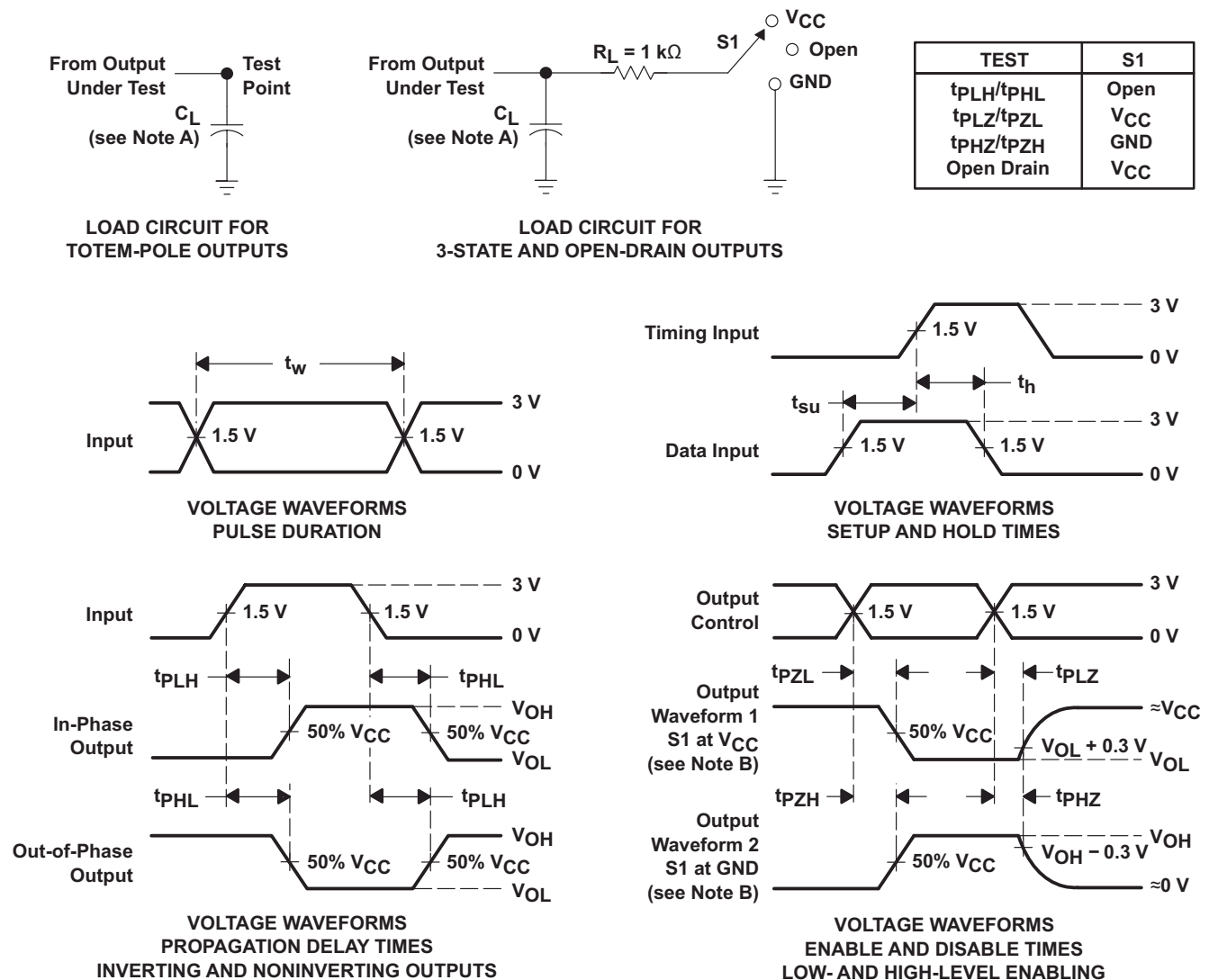
**Figure 6-2. Switching Characteristics at 50 MHz**  
Excellent Signal Integrity  
(3.3 V to 3.3 V at 3.3-V  $V_{CC}$ )



**Figure 6-3. Switching Characteristics at 15 MHz**  
Excellent Signal Integrity  
(3.3 V to 1.8 V at 1.8-V  $V_{CC}$ )



## 7 Parameter Measurement Information



- NOTES:
- A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics:  $PRR \leq 1\text{ MHz}$ ,  $Z_O = 50\ \Omega$ ,  $t_r \leq 3\text{ ns}$ ,  $t_f \leq 3\text{ ns}$ .
  - D. The outputs are measured one at a time, with one input transition per measurement.
  - E. All parameters and waveforms are not applicable to all devices.

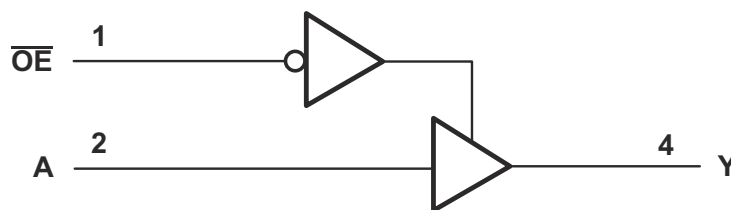
**Figure 7-1. Load Circuit and Voltage Waveforms**

## 8 Detailed Description

### 8.1 Overview

The SN74LV1T125 device is a low-voltage CMOS gate logic that operates at a wider voltage range for industrial, portable, telecom, and automotive applications. The output level is referenced to the supply voltage and is able to support 1.8-V, 2.5-V, 3.3-V, and 5-V CMOS levels. The input is designed with a lower threshold circuit to match 1.8 V input logic at  $V_{CC} = 3.3$  V and can be used in 1.8 V to 3.3 V level-up translation. In addition, the 5 V tolerant input pins enable down translation (that is, 3.3 V to 2.5 V output at  $V_{CC} = 2.5$  V). The wide  $V_{CC}$  range of 1.8 V to 5.5 V allows generation of desired output levels to connect to controllers or processors. The SN74LV1T125 device is designed with current-drive capability of 8 mA to reduce line reflections, overshoot, and undershoot caused by high-drive outputs.

### 8.2 Functional Block Diagram



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Figure 8-1. Logic Diagram

### 8.3 Feature Description

#### 8.3.1 Clamp Diode Structure

The outputs to this device have both positive and negative clamping diodes, and the inputs to this device have negative clamping diodes only as depicted in Figure 8-2.

#### CAUTION

Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

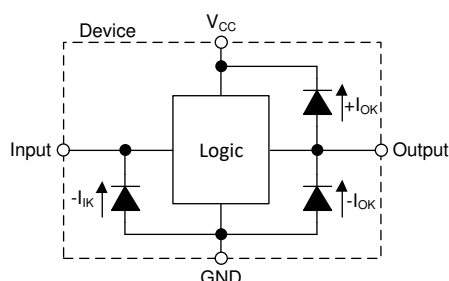


Figure 8-2. Electrical Placement of Clamping Diodes for Each Input and Output

#### 8.3.2 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs should be left disconnected.

### 8.3.3 LVxT Enhanced Input Voltage

The SN74LV1T125 belongs to TI's LVxT family of Logic devices with integrated voltage level translation. This family of devices was designed with reduced input voltage thresholds to support up-translation, and inputs tolerant of signals with up to 5.5 V levels to support down-translation. The output voltage will always be referenced to the supply voltage ( $V_{CC}$ ), as described in the *Electrical Characteristics* table. To ensure proper functionality, input signals must remain at or below the specified  $V_{IH(MIN)}$  level for a HIGH input state, and at or below the specified  $V_{IL(MAX)}$  for a LOW input state. Figure 8-3 shows the typical  $V_{IH}$  and  $V_{IL}$  levels for the LVxT family of devices, as well as the voltage levels for standard CMOS devices for comparison.

The inputs are high impedance and are typically modeled as a resistor in parallel with the input capacitance given in the *Electrical Characteristics*. The worst case resistance is calculated with the maximum input voltage, given in the *Absolute Maximum Ratings*, and the maximum input leakage current, given in the *Electrical Characteristics*, using Ohm's law ( $R = V \div I$ ).

The inputs require that input signals transition between valid logic states quickly, as defined by the input transition time or rate in the *Recommended Operating Conditions* table. Failing to meet this specification will result in excessive power consumption and could cause oscillations. More details can be found in the *Implications of Slow or Floating CMOS Inputs* application report.

Do not leave inputs floating at any time during operation. Unused inputs must be terminated at  $V_{CC}$  or GND. If a system will not be actively driving an input at all times, a pull-up or pull-down resistor can be added to provide a valid input voltage during these times. The resistor value will depend on multiple factors; however, a 10-k $\Omega$  resistor is recommended and will typically meet all requirements.

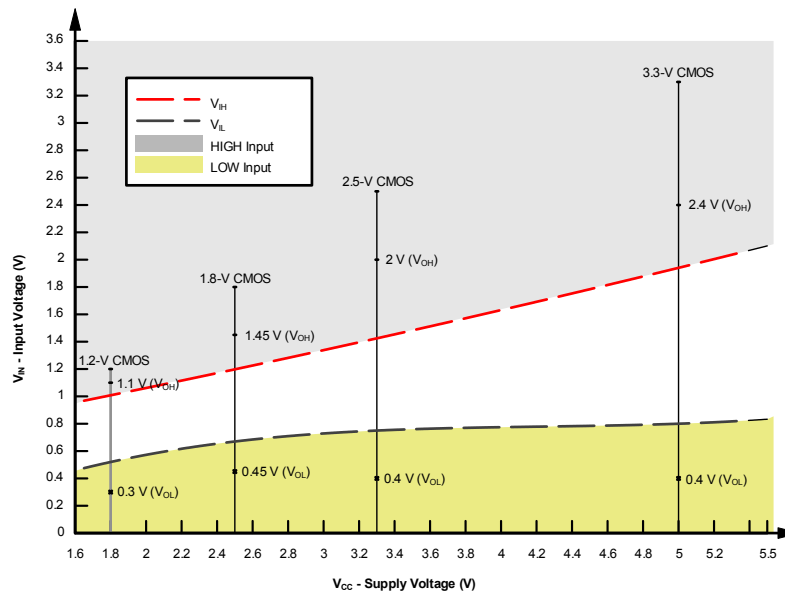


Figure 8-3. LVxT Input Voltage Levels

#### 8.3.3.1 Down Translation

Signals can be translated down using the SN74LV1T125. The voltage applied at the  $V_{CC}$  will determine the output voltage and the input thresholds as described in the *Recommended Operating Conditions* and *Electrical Characteristics* tables.

When connected to a high-impedance input, the output voltage will be approximately  $V_{CC}$  in the HIGH state, and 0 V in the LOW state. Ensure that the input signals in the HIGH state are between  $V_{IH(MIN)}$  and 5.5 V, and input signals in the LOW state are lower than  $V_{IL(MAX)}$  as shown in Figure 8-3.

For example, standard CMOS inputs for devices operating at 5.0 V, 3.3 V or 2.5 V can be down-translated to match 1.8 V CMOS signals when operating from 1.8-V  $V_{CC}$ . See Figure 8-4.

**Down Translation Combinations:**

- 1.8-V  $V_{CC}$  – Inputs from 2.5 V, 3.3 V, and 5.0 V
- 2.5-V  $V_{CC}$  – Inputs from 3.3 V and 5.0 V
- 3.3-V  $V_{CC}$  – Inputs from 5.0 V

**8.3.3.2 Up Translation**

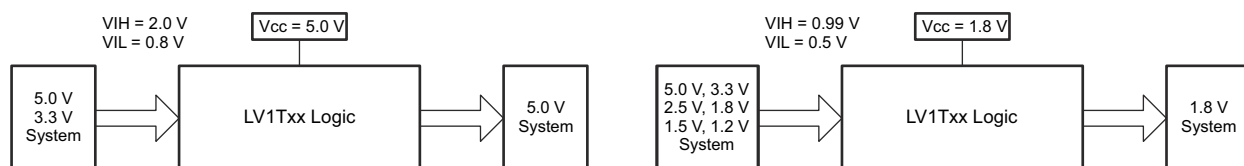
Input signals can be up translated using the SN74LV1T125. The voltage applied at  $V_{CC}$  will determine the output voltage and the input thresholds as described in the *Recommended Operating Conditions* and *Electrical Characteristics* tables. When connected to a high-impedance input, the output voltage will be approximately  $V_{CC}$  in the HIGH state, and 0 V in the LOW state.

The inputs have reduced thresholds that allow for input high-state levels which are much lower than standard values. For example, standard CMOS inputs for a device operating at a 5-V supply will have a  $V_{IH(MIN)}$  of 3.5 V. For the SN74LV1T125,  $V_{IH(MIN)}$  with a 5-V supply is only 2 V, which would allow for up-translation from a typical 2.5-V to 5-V signals.

Ensure that the input signals in the HIGH state are above  $V_{IH(MIN)}$  and input signals in the LOW state are lower than  $V_{IL(MAX)}$  as shown in [Figure 8-4](#).

**Up Translation Combinations:**

- 1.8-V  $V_{CC}$  – Inputs from 1.2 V
- 2.5-V  $V_{CC}$  – Inputs from 1.8 V
- 3.3-V  $V_{CC}$  – Inputs from 1.8 V and 2.5 V
- 5.0-V  $V_{CC}$  – Inputs from 2.5 V and 3.3 V

**Figure 8-4. LVxT Up and Down Translation Example****8.4 Device Functional Modes****Function Tables**

INPUT <sup>(1)</sup> (LOWER LEVEL INPUT)		OUTPUT <sup>(2)</sup> ( $V_{CC}$ CMOS)
OE <sup>(3)</sup>	A	Y
L	H	H
L	L	L
H	X	Z

- (1) H = High Voltage Level, L = Low Voltage Level, X = Do not Care, Z = High Impedance  
 (2) H = Driving High, L = Driving Low, Z = High Impedance State  
 (3) Not recommend to float OE pin for signal oscillation.

SUPPLY $V_{CC} = 3.3\text{ V}$		
INPUT (LOWER LEVEL INPUT)		OUTPUT ( $V_{CC}$ CMOS)
A	B	Y
$V_{IH(min)} = 1.35\text{ V}$ $V_{IL(max)} = 0.8\text{ V}$		$V_{OH(min)} = 2.9\text{ V}$ $V_{OL(max)} = 0.2\text{ V}$

## 9 Application Information Disclaimer

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### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

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## 9.1 Layout

### 9.1.1 Layout Guidelines

When using multiple-input and multiple-channel logic devices inputs must not ever be left floating. In many cases, functions or parts of functions of digital logic devices are unused; for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or  $V_{CC}$ , whichever makes more sense for the logic function or is more convenient.

## 9.2 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Recommended Operating Conditions*. Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. A 0.1- $\mu$ F capacitor is recommended for this device. It is acceptable to parallel multiple bypass caps to reject different frequencies of noise. The 0.1- $\mu$ F and 1- $\mu$ F capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results, as shown in the following layout example.

## 10 Device and Documentation Support

### 10.1 Documentation Support (Analog)

#### 10.1.1 Related Documentation

For related documentation, see the following:

- Texas Instruments, [CMOS Power Consumption and Cpd Calculation application note](#)
- Texas Instruments, [Designing With Logic application note](#)
- Texas Instruments, [Thermal Characteristics of Standard Linear and Logic \(SLL\) Packages and Devices application note](#)
- Texas Instruments, [Implications of Slow or Floating CMOS Inputs application note](#)

#### 10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on [ti.com](http://ti.com). Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 10.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

#### 10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 10.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 10.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

## 11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision C (October 2023) to Revision D (March 2024)	Page
• Updated RθJA values: DBV = 206 to 278, all values in °C/W .....	6

Changes from Revision B (June 2022) to Revision C (October 2023)	Page
• Updated <i>Package Information</i> table.....	1
• Updated RθJA values: DCK = 252 to 289.2, all values in °C/W .....	6

## 12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV1T125DBVR	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	(37RH, 3BCF, NEZ3, NEZJ, NEZS)	<a href="#">Samples</a>
SN74LV1T125DBVRG4	ACTIVE	SOT-23	DBV	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	NEZ3	<a href="#">Samples</a>
SN74LV1T125DCKR	ACTIVE	SC70	DCK	5	3000	RoHS & Green	SN	Level-1-260C-UNLIM	-40 to 125	(1QQ, WZ3, WZJ, WZS)	<a href="#">Samples</a>
SN74LV1T125DCKRG4	ACTIVE	SC70	DCK	5	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM		WZ3	<a href="#">Samples</a>

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**OTHER QUALIFIED VERSIONS OF SN74LV1T125 :**

- Automotive : [SN74LV1T125-Q1](#)

NOTE: Qualified Version Definitions:

- Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## TAPE AND REEL INFORMATION



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV1T125DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN74LV1T125DBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.2	1.4	4.0	8.0	Q3
SN74LV1T125DBVRG4	SOT-23	DBV	5	3000	178.0	9.2	3.3	3.23	1.55	4.0	8.0	Q3
SN74LV1T125DCKR	SC70	DCK	5	3000	180.0	8.4	2.3	2.5	1.2	4.0	8.0	Q3
SN74LV1T125DCKRG4	SC70	DCK	5	3000	178.0	9.2	2.4	2.4	1.22	4.0	8.0	Q3

## TAPE AND REEL BOX DIMENSIONS



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV1T125DBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
SN74LV1T125DBVR	SOT-23	DBV	5	3000	210.0	185.0	35.0
SN74LV1T125DBVRG4	SOT-23	DBV	5	3000	180.0	180.0	18.0
SN74LV1T125DCKR	SC70	DCK	5	3000	210.0	185.0	35.0
SN74LV1T125DCKRG4	SC70	DCK	5	3000	180.0	180.0	18.0



### SOT - 1.1 max height

[illegible]

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC MO-203.
4. Support pin may differ or may not be present.
5. Lead width does not comply with JEDEC.
6. Body dimensions do not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.25mm per side

# EXAMPLE BOARD LAYOUT

DCK0005A

SOT - 1.1 max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:18X



SOLDER MASK DETAILS

4214834/G 11/2024

NOTES: (continued)

7. Publication IPC-7351 may have alternate designs.
8. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE  
BASED ON 0.125 THICK STENCIL  
SCALE:18X

4214834/G 11/2024

NOTES: (continued)

9. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
10. Board assembly site may have different recommendations for stencil design.



# EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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